

Application/Control No. 10/790,752

Examiner
David J. Makiya

Applicant(s)/Patent under Reexamination
ZIRK ET AL.

Art Unit 2875

		INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS					CL	AIMED	NON-CLAIMED				
362			119		25	В	23	/18		1	
CROSS REFERENCES					26	В	11	/00			
CLASS	SUBCLA	CK)				_		·			
362	120			В	26	В	23	/00		1	
7	118	145	159					1		,	
30	308.1	308.2						1			
								1		/	
								/		1	

David Makiya 11/23/2005 (Assistant Examiner) (Date)

05

RENEE LUEBKE

PRIMARY EXAMINER (Primary Examiner) (Date)

Total Claims Allowed: 31

O.G. Print Claim(s)

O.G. Print Fig.

Claims renumbered in the same order as presented by applicant									☐ CPA						☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1		11	31			61	1		91			121			151			181
	2		29	32			62			92			122			152			182
2	3			33			63			93			123			153			183
4	4			34			64			94			124			154			184
13	5			35			65]		95			125			155			185
5	6			36			66]		96			126			156			186
7	7			37			67]		97			127			157			187
6	8			38			68			98			128			158			188
8	9			39			69]		99			129			159			189
10	10			40			70]		100			130			160			190
20	11			41			71			101			131			161			191
14	12			42			72			102			132			162			192
15	13			43			73]		103			133			163			193
16	14			44			74]		104			134			164			194
17	15			45			75			105			135			165			195
26	16			46			76]		106			136			166			196
_ 27	17			47			77]		107			137			167			197
28	18			48			78]		108			138			168			198
_30	19			49			79]		109			139			169			199
31	20			50			80]		110			140		_	170			200
_ 18	21			51			81			111			141			171			201
19	22			52			82			112			142			172			202
21	23)		53			83			113			143			173			203
22	24			54			84]		114			144		_	174			204
23	25			55			85]		115			145			175			205
24	26			56			86]		116			146			176			206
25	27			57			87			117			147		<u>-</u>	177			207
12	28			58			88]		118			148			178			208
3	29			59			89]		119			149			179			209
9	30			60	L		90	<u> </u>		120			150			180			210